

## Lifetime and mobility of electrons in the silicon $D^-$ band

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A photoconductivity involving the  $D^-$  band has been observed for the first time. The lifetime and mobility of the electrons in the  $D^-$  band in doped silicon have been determined.

It was shown in Ref. 1 that the lifetimes of photoexcited electrons in doped Si are determined by indirect recombination involving the capture of electrons by neutral impurity centers, followed by either (a) a hopping of these electrons along impurity centers or (b) a drift of the electrons through the  $D^-$  band to attraction centers, and then a recombination. The model presupposes that the captured carriers spend a fairly long time in the  $D^-$  band and can contribute to a photoconductivity.

We have observed a photoconductivity involving the  $D^-$  band ( $\sigma_g$ ) for the first time. We have determined the most important quantitative characteristics: the lifetime  $\tau_g$  and the mobility  $\mu_g$  of the electrons of the  $D^-$  band. The results were found for doped Si ( $N > 3 \times 10^{16} \text{ cm}^{-3}$ ) with a very slight compensation ( $K < 10^{-4}$ ) through measurements of the photoconductivity  $\sigma$ , the Hall constant  $R_H$ , and the photoconductivity relaxation time  $\tau_{\text{rel}}$  (Ref. 2). The experiments were carried out at a low intensity of the impurity excitation,  $W_{\text{ph}} N$  ( $W_{\text{ph}} \cong 4 \text{ s}^{-1}$ ). The results are illustrated here by the results for two Si:B samples which have identical concentrations of the main impurity ( $N \cong 5.9 \times 10^{16} \text{ cm}^{-3}$ ) but different compensating concentrations  $N_k$ : 1)  $3.5 \times 10^{13} \text{ cm}^{-3}$ ; 2)  $2 \times 10^{12} \text{ cm}^{-3}$ . We will discuss  $n$ -type materials here.

Figure 1 is a simplified diagram of the electronic transitions involved in the indirect capture. Electrons photoexcited from impurity centers (transition 1, probability

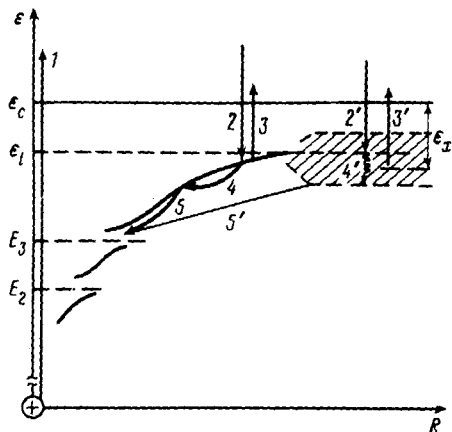


FIG. 1. Diagram of electronic transitions during indirect capture.

$W_{ph}$ ) are captured by attractive centers (a) near the attractive centers into states with an energy  $\epsilon = \epsilon(R_{eff})$  (transition 2,  $\alpha_{eff}N_k$ ; Ref. 1) and (b) far from the attractive centers, into a band of delocalized  $D^-$  states (transition 2',  $\alpha^0N$ ). For the captured electrons there are the following possibilities: (A) a thermal scattering into a free band (transitions 3, 3':  $W_t = \alpha^0N_c \exp(-\epsilon/kT)$ , where (a) either  $\epsilon \cong \epsilon(R_{eff})$  or (b)  $\epsilon \cong \epsilon_x, \epsilon_x$  is the energy position of the maximum of the electron distribution in the  $D^-$  band; (B) a descent along the energy scale in the band of  $D^-$  states (transitions 4, 4';  $W_d$ ), terminating in a capture by attractive centers (transitions 5, 5'). The lifetime in the free band is generally described by

$$\tau_c^{-1} = \alpha^0N \frac{W_d}{W_t + W_d} + \alpha_{eff}N_k, \quad (1)$$

where  $W_d$  is the reciprocal of the time required for a descent of a distance  $\cong kT$  along the energy scale, and  $\alpha_{eff}$  is the indirect capture coefficient, which is determined by the radius ( $R_{eff}$ ) of that sphere for which we have<sup>1</sup>  $W_t(R_{eff}) \cong W_d(R_{eff})$ . In the selected samples with  $N_k$  close to the threshold for the delocalization of  $D^-$  states, an increase in  $N_k$  by a factor  $\cong 20$  significantly reduces the volume of the region spanned by delocalization<sup>3</sup> and thus the relative importance of the terms in (1). At "large" values of  $N_k$  we have  $\tau_c = 1/\alpha_{eff}N_k$  (Ref. 1) and  $\sigma_c \gg \sigma_g \approx 0$ ; at "small" values of  $N_k$ , and with an extended  $D^-$  band, we have

$$\tau_c \cong (W_d + W_t)/\alpha^0NW_d \quad (2)$$

and, presumably,  $\sigma_c \cong \sigma_g \neq 0$ .

Figure 2 shows results on the behavior  $\sigma R_H(T) = \mu^*$  for sample No. 1 (curve 1) and sample No. 2 (curve 2). We see that for sample No. 1 we have  $\mu^* = \text{const} = \mu_c$  ( $\mu_c$  is the mobility corresponding to scattering by impurity centers), so that we have<sup>1</sup>  $\sigma = \sigma_c \sim 1/\alpha_{eff}N_k \sim T^{2.3}$  (curve 1'). For sample No. 2,  $\mu^*$  varies with  $T$ , implying that there are two conduction mechanisms, with different mobilities and different  $T$  depen-

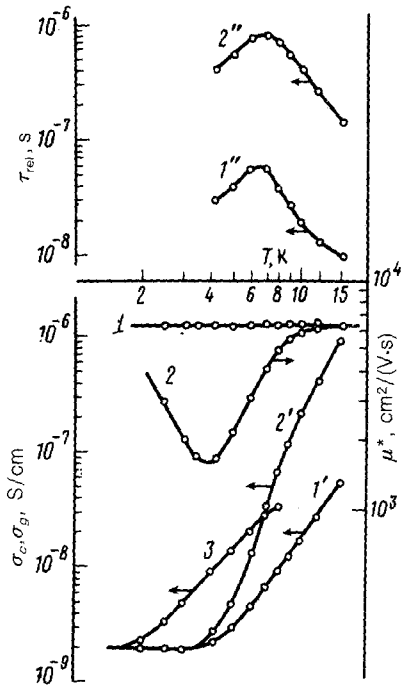


FIG. 2. Temperature dependence of  $\mu^*$ ,  $\sigma_c$ , and  $\tau_{rel}$  for sample No. 1 (1, 1', 1'', respectively) and for sample No. 2 (2, 2', 2'');  $\sigma_g(T)$  for sample No. 2 (curve 3).

dences. Under the assumption  $\mu_g/\mu_c \ll 1$ , and in weak magnetic fields  $H$  [ $(\mu_g H/c)^2 \ll 1$ ], we can ignore the contribution of the  $D^-$  carriers to the Hall field. According to the two-band conductivity model, we would then have

$$R_H = \frac{\sigma_c \mu_c}{(\sigma_c + \sigma_g)^2 + \sigma_g^2 \mu_c^2 H^2 / c^2}; \quad \sigma = \sigma_c + \sigma_g. \quad (3)$$

Analyzing the data with the help of (3), we find the values of  $\sigma_c$  (curve 2') and  $\sigma_g$  (curve 3). We have  $\sigma_g \sim T^2$ , and the dependence  $\sigma_c(T)$  at  $5 \text{ K} < T < 10 \text{ K}$  is approximately exponential,  $\sigma_c \sim \tau_c \sim N_c \exp(-\epsilon_x/kT)$  (curve 2 in Fig. 3), where  $\epsilon_x \cong 36 \text{ K}$ ; i.e.,  $\tau_c$  corresponds to expression (2) at  $W_i \gg W_d$  ( $W_d = W_i$  at  $T = T_k \cong 5 \text{ K}$ ). The behavior of the ratio  $\sigma_g/\sigma_c$  as a function of  $T$  is shown by the dashed line in Fig. 3. At  $T = 4.2 \text{ K}$  we have  $\sigma_g/\sigma_c \cong 3$ . For sample No. 2 at  $T = 4.2 \text{ K}$ , the photoconductivity is provided primarily by the  $D^-$  band, and the relaxation of the transient photoconductivity should correspond to the relaxation of  $\sigma_g$ .

Let us examine the processes responsible for the relaxation of the photoconductivity in these samples. For the relaxation time of  $\sigma_c$  we find the following approximate results<sup>2)</sup> from the kinetic equations:

$$\tau_{rel}(\sigma_c) \cong \tau_c \left( 1 + \frac{\alpha^0 N}{W_i + W_d} \right). \quad (4)$$

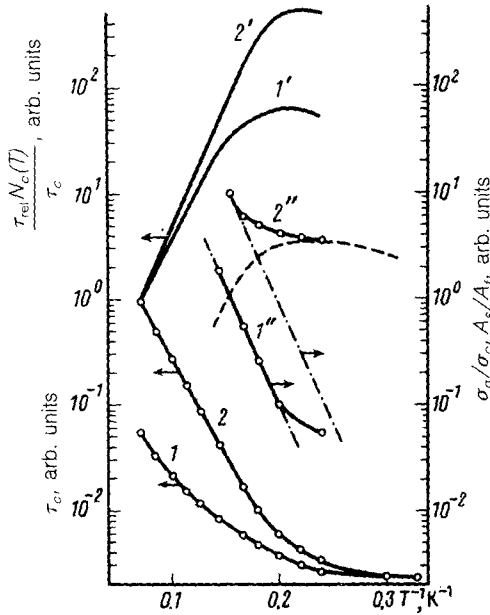


FIG. 3. Temperature dependence of  $\tau_c$ ,  $(\tau_{\text{rel}} N_e)/\tau_c$ , and  $A_s/A_f$  for sample No. 1 (1, 1', 1'', respectively), and for sample No. 2 (2, 2', 2'', respectively). Dashed line—behavior of  $\sigma_g/\sigma_c$ ; dot-dashed line—calculated behavior of  $A_s/A_f = W_i/W_d$  for sample No. 2.

At  $W_i \gg W_d$  the impurity centers serve as ordinary attachment levels,<sup>4</sup> and the decay of  $\sigma_c$  is described by a single time constant. Here the behavior of  $\log(\tau_{\text{rel}} N_e/\tau_c)$  as a function of  $1/T$  is linear (curves 1' and 2' in Fig. 3). From the slope of curve 2' we can find  $\epsilon_x$ . The value that we find,  $\epsilon_x \cong 38$  K, is close to the value for  $\epsilon_x$  found from the curve of  $\tau_c(T)$  for sample No. 2.

Under the condition  $W_i < W_d$  we have, for indirect capture  $\tau_c = 1/\alpha^0 N$  and  $\tau_{\text{rel}}(\sigma_c) = W_d^{-1}$ ; i.e., the relaxation time of  $\sigma_c$  is determined by the cooling time of the electrons in the band of  $D^-$  states. Furthermore, two characteristic regions should be observed on the curve of the decay of the photoconductivity pulse: a region with a fast decay (with an amplitude  $A_f$  and  $\tau = \tau_c$ ) and a region with a slow decay (with an amplitude  $A_s$  and  $\tau \cong W_d^{-1}$ ) of  $\sigma_c$ . The amplitude ratio  $A_s/A_f$  should fall off exponentially with decreasing  $T$ . The reason for this decrease is that the ratio of the rate of generation from  $D^-$  centers and the rate of generation from impurity centers decreases with decreasing  $T$ : At  $W_i < W_d$  the number of carriers in  $D^-$  states ( $n_g$ ) is determined by the value of  $W_d$ :  $n_g = W_{\text{ph}} N / W_d$ , so that we have  $A_s/A_f \cong n_g W_i / W_{\text{ph}} N \cong W_i / W_d$ . This dependence  $A_s/A_f(T)$  is exhibited by sample No. 1 (curve 1'' in Fig. 3).

The relaxation of  $\sigma_g$  is determined by the time spent by electrons of the  $D^-$  band in a conducting state:  $\tau_g$ . The times  $\tau_g$  and  $W_d^{-1}$  are not identical, but they are similar in meaning and (apparently) in magnitude. Accordingly, again in sample No. 2, in the region in which  $\sigma_g$  is dominant, we should observe a photoconductivity with a decay constant close to  $W_d^{-1}$  (Fig. 2).

In summary, measurements of solely the decay constants of the photoconductivity-

ty are not capable of distinguishing  $\sigma_g$  from  $\sigma_c$ . The dependence  $A_s/A_f(T)$  is important for identifying the photoconductivity mechanism. Figure 3 shows a calculated curve of  $A_s/A_f$  for sample No. 2 found by ignoring  $\sigma_g$  (the dot-dashed line). Also shown here are the experimental results on  $A_s/A_f(T)$  (curve 2''). The experimental results are radically different from the theoretical predictions; the measured values of the ratios  $A_s/A_f$  and  $\sigma_g/\sigma_c$  are approximately the same at  $T = 4.2$  K. We perceive this fact as independent confirmation that a  $D^-$ -band photoconductivity is exhibited by sample No. 2 at  $T < 5$  K. The value measured for  $\tau_{rel}$  in this case corresponds to  $\tau_g$  ( $\tau_g \cong 4 \times 10^{-7}$  s). Hence, knowing  $\sigma_g$  and  $N_k$  and assuming  $\tau_g = 1/\alpha_g N_k$ , we find values for  $\mu_g$  and  $\alpha_g$ :  $\mu_g \cong 1$  cm/(V·s) and  $\alpha_g \cong 10^{-6}$  cm<sup>3</sup>/s.

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<sup>2</sup>This question will be examined in detail in a separate paper.

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<sup>4</sup>S. M. Ryvkin, Photoelectric Effects in Semiconductors, Moscow, 1963, Chap. 6.

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